



Ref. Certif. No.

CN24060

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST  
CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE)  
CB SCHEMESYSTEME CEI D'ACCEPTATION MUTUELLE DE  
CERTIFICATS D'ESSAIS DES EQUIPEMENTS  
ELECTRIQUES (IECEE) METHODE OC

## CB TEST CERTIFICATE

Product  
Produit

Moulded Case Circuit-breaker

Name and address of the applicant  
Nom et adresse du demandeurSchneider Electric Low Voltage (Tianjin) Co., Ltd.  
No 66 Muning Road, 7th Avenue, TEDA, Tianjin, P.R. ChinaName and address of the manufacturer  
Nom et adresse du fabricantSchneider Electric Low Voltage (Tianjin) Co., Ltd.  
No 66 Muning Road, 7th Avenue, TEDA, Tianjin, P.R. ChinaName and address of the factory  
Nom et adresse de l'usineSchneider Electric Low Voltage (Tianjin) Co., Ltd.  
No 66 Muning Road, 7th Avenue, TEDA, Tianjin, P.R. ChinaNote: When more than one factory, please report on page 2  
Note: Lorsqu'il y a plus d'une usine, veuillez utiliser la 2<sup>ème</sup> pageRatings and principal characteristics  
Valeurs nominales et caractéristiques principales

Ue DC125V(1P), DC250V(2P), In 1A, 2A, 3A, 4A, 6A, 10A, 16A, 20A, 25A, 30A, 32A, 40A, 50A, 63A, Icu=10kA, Ics=7.5kA; Utilization category: A; IP: 2P, circuit as appendix

Trademark (if any)  
Marque de fabrique (si elle existe)

Schneider Electric

Model / Type Ref.  
Ref. De type

C65H-DC, C60N-DC

Additional information (if necessary may also be reported  
on page 2)  
Les informations complémentaires (si nécessaire, peuvent être  
indiqués sur la 2<sup>ème</sup> page)

PUBLICATION

EDITION

A sample of the product was tested and found  
to be in conformity with  
Un échantillon de ce produit a été essayé et a été  
considéré conforme à la

IEC 60947-2:2006(4 th edition)+ amendment 1 2009

As shown in the Test Report Ref. No. which forms part  
of this Certificate  
Comme indiqué dans le Rapport d'essais numéro de  
référence qui constitue partie de ce Certificat

C009-CB2011CQC-038645

This CB Test Certificate is issued by the National Certification Body  
Ce Certificat d'essai OC est établi par l'Organisme National de Certification

CHINA QUALITY CERTIFICATION CENTRE

Date: 2012-07-27

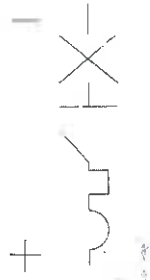
Signature:

Wang Kejiao

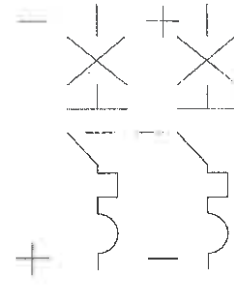
Issued 2003-05  
China Quality Certification Centre  
Section 9, No. 188, Nansihuan Xilu, Beijing 100070 P.R. ChinaTel: +86-10-83886666  
Fax: +86-10-83886282website  
www.cqc.com.cn

CB 0017607

CN24060



1P



2P

证书专用



Test Report issued under the responsibility of:



**TEST REPORT**  
**IEC 60947-2**  
**Low-voltage switchgear and controlgear - Part 2: Circuit-breakers**

Report Reference No ..... C009-CB2011CQC-038645

Date of issue ..... 2012-06-29

Total number of pages ..... 158



CB Testing Laboratory ..... Shanghai Testing & Inspection Institute for Electrical Equipment (STIEE)  
Address ..... 505 Wu Ning Rd. Shanghai 200063 P.R. CHINA

Applicant's name ..... Schneider Electric Low Voltage(Tianjin) Co.,Ltd  
Address ..... No.66 Muning Road ,7th Avenue,TEDA,Tianjin,P.R.China

**Test specification:**

Standard ..... IEC 60947-2:2006 (4<sup>th</sup> Edition) + amendment 1: 2009

Test procedure ..... CB

Non-standard test method ..... N/A

Test Report Form No ..... IEC60947\_2F

Test Report Form(s) Originator ..... KEMA Quality BV

Master TRF ..... Dated 2010-01

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This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.


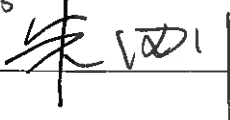
Test item description ..... Moulded Case Circuit-Breaker

Trade Mark ..... Schneider Electric

Manufacturer ..... Schneider Electric Low Voltage(Tianjin) Co.,Ltd.

Model/Type reference ..... C65H-DC, C60N-DC

Ratings ..... C65H-DC, C60N-DC: Ue: DC125V(1P), DC250V (2P);  
In: 1A, 2A, 3A, 4A, 6A, 10A, 16A, 20A, 25A, 30A, 32A, 35A, 40A, 50A, 63A;

Testing procedure and testing location:	
<input checked="" type="checkbox"/> <b>CB Testing Laboratory:</b>	Shanghai Testing & Inspection Institute for Electrical Equipment (STIEE)
Testing location/ address.....:	505 Wu Ning Rd. Shanghai 200063, P.R. CHINA
<input type="checkbox"/> <b>Associated CB Laboratory:</b>	N/A
Testing location/ address.....:	N/A
Tested by (name + signature) .....	Gao Yanbo 
Approved by (+ signature) .....	Zhu Gang 
<input type="checkbox"/> Testing procedure: TMP	N/A
Tested by (name + signature) .....	N/A
Approved by (+ signature).....:	N/A
Testing location/ address.....:	N/A
<input type="checkbox"/> Testing procedure: WMT	N/A
Tested by (name + signature) .....	N/A
Witnessed by (+ signature).....:	N/A
Approved by (+ signature).....:	N/A
Testing location/ address.....:	N/A
<input type="checkbox"/> Testing procedure: SMT	N/A
Tested by (name + signature) .....	N/A
Approved by (+ signature).....:	N/A
Supervised by (+ signature) .....	N/A
Testing location/ address.....:	N/A
<input type="checkbox"/> Testing procedure: RMT	N/A
Tested by (name + signature) .....	N/A
Approved by (+ signature).....:	N/A
Supervised by (+ signature) .....	N/A
Testing location/ address.....:	N/A

**Summary of testing:****Tests performed (name of test and test clause):**

Type	Ue(V)	In(A)	Poles	Sequence
C60N-DC(C curve)	DC250	63	2	I
C60N-DC(B curve)	DC125	63	1	I
C65H-DC(C curve)	DC250	63	2	I
C65H-DC(C curve)	DC125	32	1	I
C60N-DC(C curve)	DC250	63	2	II
C60N-DC(C curve)	DC250	1	2	II
C65H-DC(C curve)	DC250	63	2	II
C65H-DC(C curve)	DC250	1	2	II
C60N-DC(B curve)	DC125	63	1	II
C60N-DC(B curve)	DC125	1	1	II
C65H-DC(B curve)	DC125	63	2	II
C65H-DC(B curve)	DC125	1	2	II
C65H-DC(C curve)	DC250	63	2	III
C65H-DC(C curve)	DC250	1	2	III
C60N-DC(B curve)	DC125	63	1	III
C60N-DC(B curve)	DC125	1	1	III
C65H-DC(C curve)	DC250	63	2	III
C65H-DC(C curve)	DC125	32	1	III
C65H-DC Enclosure color: white	DC250	63	2	III
C65H-DC Enclosure color: white	DC125	63	1	III

**Testing location:**

Shanghai Testing & Inspection Institute for Electrical Equipment (STIEE)  
505 Wu Ning Rd. Shanghai 200063, P.R. CHINA

**Summary of compliance with National Differences: N/A**